

Notice of References Cited	Application/Control No. 10/814,729		Applicant(s)/Patent Under Reexamination NGUYEN ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2007/0204036 A1	08-2007	Mohaban et al.	709/224
*	B	US-7,002,974 B1	02-2006	Deerman et al.	370/401
*	C	US-2003/0223361 A1	12-2003	Hussain et al.	370/230
*	D	US-2005/0111360 A1	05-2005	Jin et al.	370/229
*	E	US-2003/0214905 A1	11-2003	Solomon et al.	370/229
*	F	US-2006/0209796 A1	09-2006	Scott, Mark	370/352
*	G	US-6,798,746 B1	09-2004	Kloth et al.	370/235
*	H	US-2002/0103925 A1	08-2002	Sheth et al.	709/236
*	I	US-7,463,628 B1	12-2008	Parker et al.	370/392
*	J	US-7,292,591 B1	11-2007	Parker et al.	370/401
*	K	US-2005/0117576 A1	06-2005	McDysan et al.	370/389
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	Q					
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	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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